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Bandyopadhyay, S., Cahay, M. Are spin junction transistors suitable for signal processing? Applied Physics Letters, 86, 133502 (2005). Copyright © 2005 AIP Publishing LLC.

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Are spin junction transistors suitable for signal processing?

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(Received 27 September 2004; accepted 26 January 2005; published online 21 March 2005)

A number of spintronic analogs of bipolar junction transistors have been proposed for signal processing applications. Here, we show that some of these transistors unfortunately may not have sufficient voltage and current gains for signal processing. They may also have poor isolation between input and output terminals which hinders unidirectional propagation of logic signal from the driver stage to the output. Therefore, these devices may not *improve* state-of-the-art signal processing capability, although they may provide some additional functionality by offering nonvolatile storage. They may also have niche applications in nonlinear circuits. © 2005 American Institute of Physics. [DOI: 10.1063/1.1883722]

There is a tacit belief in the spintronics community that adding spin to electronics will enhance the latter's capability.¹ Accordingly, a number of spin analogs of conventional bipolar junction transistors have been $proposed^{2-5}$ for signal processing applications. Here, we examine whether such devices are actually suitable for that role.

"Analog" type of signal processing usually requires devices to have both large current and voltage gain for power amplification. "Digital" signal processing has other requirements,⁶ three of which are that (i) the processing device must have a large voltage gain to regenerate logic levels at signal nodes, (ii) a large current gain for adequate fan out, and (iii) no feedback from the output terminal to the input terminal (a property known as "isolation between input and output") so that logic signal can propagate *unidirectionally* from the input to the output. A conventional transistor has all these attributes and therefore has been the workhorse of analog and digital (as well as "mixed signal") circuits. Spin transistors need to have the same attributes to be useful.

Transistors have two basic types: the field effect type (FET) and the bipolar junction type (BJT). In this letter, we will consider only spin analogs of the latter, since we had already examined the device potentials of spintronic FETs earlier.⁷ Two varieties of spin-BJTs have been proposed: (i) unipolar spin junction transistor (USJT) that mimics a conventional BJT,² and (ii) bipolar spin junction transistor (BSJT) whose base is ferromagnetic and has a nonzero equilibrium spin polarization.^{3–5}

We consider first the USJT of Ref. 2. This device consists of three layers of spin polarized material which act as emitter, base, and collector. In the emitter and collector layers, spin of one kind (say, "downspin") is majority, while in the base, spin of the other kind ("upspin") is majority. Since all three layers can have the same charge polarity, the device is "unipolar," but operationally it mimics a conventional BJT. Reference 2 derived the expressions for the collector current I_C and emitter current I_E as functions of the emitterbase bias V_{EB} and collector-base bias V_{CB} :

$$I_{C} = -\frac{qJ_{0}}{\sinh(W/L)} [(e^{-qV_{EB}/kT} - 1) - (e^{-qV_{CB}/kT} - 1) \\ \times \cosh(W/L)] - qJ_{0}(e^{qV_{CB}/kT} - 1),$$
(1)

$$I_{E} = -\frac{qJ_{0}}{\sinh(W/L)} [(e^{-qV_{EB}/kT} - 1)\cosh(W/L) - (e^{-qV_{CB}/kT} - 1)] + qJ_{0}(e^{qV_{EB}/kT} - 1),$$
(2)

where qJ_0 is the constant saturation current, W is the base width, and L is the minority spin diffusion length (assumed same in all layers).⁸ In the active mode of operation, V_{EB} <0 and $V_{CB}>0$.

In Fig. 1(a), we show the universal low-frequency smallsignal equivalent circuit of a BJT,⁹ which applies to both the USJT and BSJT. First, we will derive expressions for two small-signal parameters—the transconductance g_m and the output conductance g_o —in the "active mode." They are given by:¹⁰

$$g_{m} = \left. \frac{\partial I_{C}}{\partial V_{EB}} \right|_{V_{BC} = \text{constant}} = \frac{q^{2} J_{0}}{kT \sinh(W/L)} e^{q|V_{EB}|/kT}$$

$$g_{o} = - \left. \frac{\partial I_{C}}{\partial V_{CB}} \right|_{V_{EB} = \text{constant}}$$

$$\approx \frac{q^{2} J_{0}}{kT} e^{q|V_{CB}|/kT}$$
(3)

The output conductance g_o can be quite large. If we assume realistic values, e.g., $qJ_0=1$ fA, and $|V_{CB}|=1$ V, then $g_o \approx 9000$ S, which is extremely large. The situation can be improved slightly by having a larger spin splitting in the collector than in the emitter. In that case, the exponent in the last term of Eq. (1) will be modified as $V_{CB} \rightarrow V_{CB}$ $-\Delta_c + \Delta_b$, where Δ_c and Δ_b are the spin splittings in the

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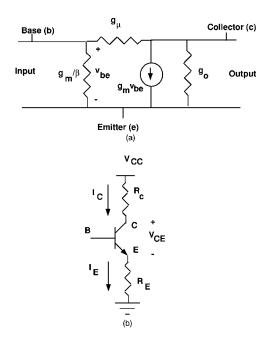


FIG. 1. (a) Universal low-frequency small-signal equivalent circuit of a BJT which applies to both USJT and BSJT. The small signal conductances are shown; (b) a biased transistor.

collector and base, respectively. Accordingly, $g_o \approx q^2 J_0 / (kT) e^{(q|V_{CB}| - \Delta_c + \Delta_b)/kT}$.

Realistically, spin splitting energies in known materials hardly exceed kT at room temperature. Therefore, if we assume that $\Delta_c - \Delta_b = 25$ mV, then $g_o = 3330$ S, which is ~ 3 times smaller, but still very large. Of course, we can improve the situation by choosing smaller values of $|V_{EB}|$ and $|V_{CB}|$, but this is not advisable. The voltage levels must be several times larger than the thermal voltage kT/q to preserve good noise margin.

Using the above results, we find that the small signal voltage gain in the common emitter or common-base configuration (the voltage gain in common-collector configuration is always less than unity) is⁹

$$a_{v} = |g_{m}/g_{o}| = \frac{\exp[(q|V_{EB}| - q|V_{CB}| + \Delta_{c} - \Delta_{b})/kT]}{\sinh(W/L)}.$$
 (4)

If we assume $|V_{EB}|=0.7V$, $|V_{EB}|=1V$ and W/L=0.001, then $a_v=0.017$, which is far less than unity.

One obvious way to make the voltage gain larger than unity, is to make $|V_{EB}| > |V_{CB}|$. But this poses a problem. When the transistor is in the "off" state and $I_C, I_E \approx 0$, the emitter-base forward bias voltage $|V_{EB}|$ must be approximately 0 [see Eqs. (1) and (2)]. Therefore, if $|V_{EB}| > |V_{CB}|$, then $|V_{CB}| \approx 0$. Consequently, $V_{CE} = V_{CB} + V_{BE} \approx 0$ but now, consider the biased transistor circuit shown in Fig. 1(b). Kirchoff's voltage law dictates that $V_{CC} = I_C R_C + I_E R_E + V_{CE}$. Since near the "off" state, I_C , I_E , and V_{CE} are all approximately zero, then $V_{CC} \approx 0$ as well! Therefore, we have an inconsistency. The transistor can never be switched off unless the power supply voltage is vanishingly small. We can of course designate the "off" state to be one with nonzero collector and emitter currents, but this leads to unacceptable standby power dissipation since current will be flowing through the transistor even when it is "off". On the other hand, if we work with a vanishingly small power supply voltage, then we operate with unacceptable noise margin and furthermore, the logic levels ("on" and "off" states) are not well separated, leading to unacceptable bit error rates. Therefore, we cannot operate under the condition that $|V_{EB}| > |V_{CB}|$. In other words, we are constrained to operate with a small voltage gain, which is good for neither digital, nor analog circuitry.

Next, we calculate the small-signal feedback conductance g_{μ} which is defined as $g_{\mu} = \partial I_B / \partial V_{CB}$ (Ref. 10) evaluated at a constant value of V_{EB} , where $I_B = I_E - I_C$. As is evident from Fig. 1(a), the physical significance of g_{μ} is that it is a measure of the isolation between the output and input of the transistor since this conductor connects the output to the input. Ideally, $g_{\mu}=0$, which implies perfect isolation. However, after some algebra, we can show that in the active mode

$$g_{\mu} \approx \frac{q^2 J_0}{kT} e^{(q|V_{CB}| - \Delta_c + \Delta_b)/kT} \approx g_0.$$
⁽⁵⁾

For a normal BJT, this quantity is approximately $q^2 J_0/(kT) e^{-q|V_{CB}|/kT}$. Therefore the g_{μ} for a USJT is about $e^{(2q|V_{CB}|-\Delta_c+\Delta_b)/kT}$ times larger than for a normal BJT. Again, if we assume that $|V_{CB}|=1$ V and $\Delta_c - \Delta_b = 25$ mV, we find that the g_{μ} for a USJT is more than 10^{34} times worse than that for a conventional BJT, resulting in that much poorer isolation between the input and the output of the transistor. Isolation is an extremely important issue since there must exist a unilateral cause–effect relationship between the input and the output of a logic device. Without sufficient isolation between the input and output, it is impossible to ensure this relationship.

Next, we consider the short circuit current gain of a USJT. This is given by 9^{9}

$$a_i = \frac{\beta_0 (1 - g_\mu / g_m)}{1 + \beta_0 g_\mu / g_m},\tag{6}$$

where $\beta_0 = I_C / I_B$. If $g_\mu = 0$, then $a_i = \beta_0$, which can be very large but if $g_\mu \neq 0$, then using Eqs. (3)–(6), we find that

$$a_i \approx \frac{\beta_0 (1 - 1/a_v)}{1 + \beta_0 / a_v}.\tag{7}$$

Since a_v is small, the short circuit current gain is degraded from β_0 , and will be small. In fact, if $a_v \ll 1$, then $a_i \approx -1$. This degradation is a consequence of a nonzero g_{μ} .

We conclude that a USJT is *not* competitive with conventional BJTs for mainstream analog or digital signal processing applications since it has much larger output and feedback conductances. Of course, that does not preclude other niche applications for the USJT.

Now, we consider the BJST device of Refs. 3 and 8. Since this device is very similar to a conventional BJT, with the only difference being that the base is ferromagnetic, we will be able to directly compare it with a conventional BJT. Using the current expressions derived in Ref. 11 for an *npn* transistor, we get

$$I_C = qA \frac{D_{nb}}{L_{nb}} \frac{1}{\sinh(W/L_{nb})} n_{be} (e^{qV_{EB}/kT} - 1)$$
$$- qA \frac{D_{nb}}{L_{nb}} \coth(W/L_{nb}) n_{bc} (e^{qV_{CB}/kT} - 1)$$

ct to the ter $qA \frac{D_{pc}}{dc} \operatorname{coth}(W_c/L_{pc}) p_{oc}(e^{qV_{CP}/kT} + 1)$ jons. Downlo(8) d to IP: 5 Apr 2015 18:02941

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$$I_{E} = qA \frac{D_{nb}}{L_{nb}} \operatorname{coth}(W/L_{nb}) n_{be} (e^{qV_{EB}/kT} - 1)$$

- $qA \frac{D_{nb}}{L_{nb}} \frac{1}{\sinh(W/L_{nb})} n_{bc} [e^{qV_{CB}/kT} - 1]$
+ $qA \frac{D_{pe}}{L_{pe}} \operatorname{coth}(W_{e}/L_{pe}) p_{oe} [e^{qV_{EB}/kT} - 1],$ (9)

where A is the cross-sectional area of the transistor, W_c is the width of the collector, W_e is the width of the emitter, $D_{nb}(L_{nb})$ is the minority carrier diffusion constant (length) for electrons in the base, $D_{pc}(L_{pc})$ is the minority carrier diffusion constant (length) for holes in the collector, $D_{pe}(L_{pe})$ is the minority carrier diffusion constant (length) for $n_{be} = (n_i^2 / N_{AB})(1 + \alpha_e \alpha_{0b}) /$ holes in the emitter, $\sqrt{1-\alpha_{0b}^2}, n_{bc}=(n_i^2/N_{AB})(1+\alpha_c\alpha_{0b})/\sqrt{1-\alpha_{0b}^2}, p_{oc}=(n_i^2/N_{DC}),$ $p_{oe} = (n_i^2 / N_{DE}), n_i$ is the intrinsic carrier concentration in the material, N_{AB} is the acceptor dopant concentration in the base, N_{DC} is the donor dopant concentration in the collector, N_{DE} is the donor dopant concentration in the emitter, α_e and α_c are the nonequilibrium spin polarizations in the emitter and collector, α_{0b} [=tanh(Δ/kT)] is the equilibrium spin polarization in the base, and 2Δ is the magnitude of energy splitting between the majority and minority spin in the base.

As before, we calculate the small signal parameters in the active mode:

$$g_{m} = \left. \frac{\partial I_{C}}{\partial V_{EB}} \right|_{V_{BC} = \text{constant}}$$

$$g_{o} = \left. \frac{\partial I_{C}}{\partial V_{CE}} \right|_{V_{EB} = \text{constant}}$$

$$g_{\mu} = \left. \frac{\partial I_{B}}{\partial V_{CE}} \right|_{V_{EB} = \text{constant}}$$
(10)

If we generously assume that the equilibrium spin polarization in the base is larger than 76% so that $\Delta > kt$, and additionally if we assume that the base and collector dopings are about equal, as well as the base and collector widths are about equal, then it is straightforward to show that the parameters of a BSJT and a conventional BJT compare as:

$$\frac{g_m(BSJT)}{g_m(BJT)} = [1 + \alpha_e \tanh(\Delta/kT)]e^{\Delta/kT}$$

$$\frac{g_o(BSJT)}{g_o(BJT)} = [1 + \alpha_e \tanh(\Delta/kT)]e^{\Delta/kT}$$

$$\frac{g_\mu(BSJT)}{g_\mu(BJT)} = [1 + \alpha_e \tanh(\Delta/kT)]e^{\Delta/kT}$$

$$\frac{a_v(BSJT)}{a_v(BJT)} = [1 + \alpha_e \tanh(\Delta/kT)]/[1 + \alpha_e \tanh(\Delta/kT)] \approx 1$$

$$\frac{a_i(BSJT)}{a_i(BJT)} = 1$$
(11)

where we have used Eq. (6) to evaluate the ratio of the current gains.

The above comparison shows that there is no significant advantage or disadvantage of a BSJT compared to a conventional BJT as far as current and voltage gains are concerned. However, there is a drawback in terms of having a larger feedback conductance g_{μ} which degrades isolation between input and output of the device, and this impairs logic functionality. The degradation becomes progressively worse with increasing Δ or increasing spin polarization in the base. Because of this, it is unlikely that a BSJT will replace a BJT in digital signal processing applications.

In conclusion, we have found that spin analogs of bipolar junction transistors do not offer an advantage over their conventional counterparts in mainstream signal processing applications. This is consistent with our earlier finding regarding spin analogs of field effect transistors.⁷ We stress that neither the proponents of spin-BJTs, nor the proponents of spin-FETs claimed explicitly that their devices have an advantage over conventional transistors in signal processing. The small signal analysis in this letter confirms that there is indeed no such advantage. However, spin transistors do have some special features that are absent in their conventional counterparts. They can store information via magnetism and perform nonconventional tasks such as spin filtering,⁴ magnetic field sensing,¹² etc. The current gains of BSJTs depend on the degree of spin polarization in the base, which can be altered with an external magnetic field using the Zeeman effect. This feature can be exploited to realize mixers/ modulators and other nonlinear circuits. For example, if the base current is a sinusoid with angular frequency ω_1 and the external magnetic field is sinusoidal with angular frequency ω_2 , then the collector current will have frequencies $\omega_1 \pm \omega_2$. Therefore, it appears that the role of spin transistors is not in mainstream digital and analog applications, but perhaps in unusual applications where their unique features make them particularly suitable entities.

The work of S. B. was supported by the Air Force Office of Scientific Research under Grant No. FA9550-04-1-0261. We acknowledge fruitful discussions with Dr. Jaroslav Fabian and Dr. Michael Flatté.

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